

## 1. General description

WeEnPACK-B1 module with WeEn 1200V Gen2 SiC MOSFET and Solder pin type. NTC temperature sensor inside.



## 2. Features and benefits

- 3-phase full bridge topology
- Solder pin configuration
- Low ON resistance
- Low switching losses
- Reduced  $Q_g$  and  $C_{rss}$
- Minimized circuit impedance
- Robust product design

## 3. Applications

- EV chargers
- Energy storage and solar energy systems
- Power Inverters
- AC/DC converters
- Power factor correctors
- Motor drives

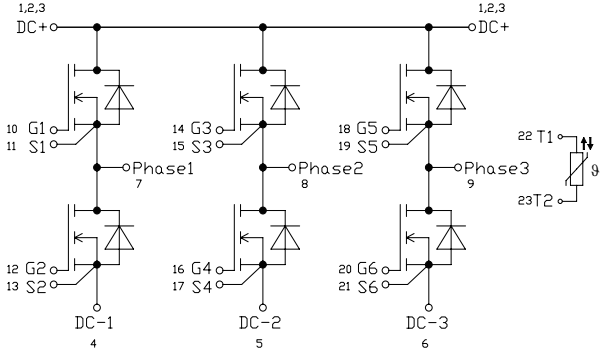
## 4. Quick reference data

Table 1. Quick reference data

| Symbol                  | Parameter                        | Conditions                                                                                                             | Notes | Values     |      |     | Unit |
|-------------------------|----------------------------------|------------------------------------------------------------------------------------------------------------------------|-------|------------|------|-----|------|
| Absolute maximum rating |                                  |                                                                                                                        |       |            |      |     |      |
| V <sub>DS</sub>         | drain-source voltage             | T <sub>j</sub> = 25 °C                                                                                                 |       | 1200       |      |     | V    |
| I <sub>D</sub>          | drain current                    | V <sub>GS</sub> = 18 V; T <sub>h</sub> = 25 °C                                                                         |       | 59         |      |     | A    |
| P <sub>tot</sub>        | total power dissipation          | T <sub>h</sub> = 25 °C                                                                                                 |       | 91         |      |     | W    |
| T <sub>J,op</sub>       | maximum junction temperature     |                                                                                                                        |       | -40 to 150 |      |     | °C   |
| Symbol                  | Parameter                        | Conditions                                                                                                             | Notes | Min        | Typ  | Max | Unit |
| Static characteristics  |                                  |                                                                                                                        |       |            |      |     |      |
| R <sub>DS(on)</sub>     | drain-source on-state resistance | V <sub>GS</sub> = 15 V; I <sub>D</sub> = 50 A; T <sub>j</sub> = 25 °C                                                  |       | -          | 20   | -   | mΩ   |
|                         |                                  | V <sub>GS</sub> = 18 V; I <sub>D</sub> = 50 A; T <sub>j</sub> = 25 °C                                                  |       | -          | 16.3 | 29  | mΩ   |
| Dynamic characteristics |                                  |                                                                                                                        |       |            |      |     |      |
| Q <sub>G(tot)</sub>     | total gate charge                | I <sub>D</sub> = 50 A; V <sub>DS</sub> = 800 V; V <sub>GS</sub> = -4 V/18 V; T <sub>j</sub> = 25 °C                    |       | -          | 215  | -   | nC   |
| Q <sub>GD</sub>         | gate-drain charge                |                                                                                                                        |       | -          | 32   | -   | nC   |
| Source-drain diode      |                                  |                                                                                                                        |       |            |      |     |      |
| Q <sub>r</sub>          | recovered charge                 | I <sub>SD</sub> = 50 A; V <sub>GS</sub> = -4 V/18 V; V <sub>R</sub> = 600 V; di/dt = 2300 A/μs; T <sub>i</sub> = 25 °C |       | -          | 1072 | -   | nC   |

5. Pinning information

Table 2. Pinning information

| Simplified outline                                                                                                                                               | Graphic symbol                                                                     |
|------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------------------------------------------|
|  <p>* Please refer to the package outline description for actual pin order.</p> |  |

6. Ordering information

Table 3. Ordering information

| Type number   | Package Name | Orderable part number | Packing method | Small packing quantity | Package version  | Package issue date |
|---------------|--------------|-----------------------|----------------|------------------------|------------------|--------------------|
| WMSC020S12B1S | WeEnPACK-B1  | WMSC020S12B1S6T       | Tray           | 24                     | WeEnPACK-B1PSB-D | 23-Jun-2025        |

7. Marking

Table 4. Marking codes

| Type number   | Marking codes |
|---------------|---------------|
| WMSC020S12B1S | WMSC020S12B1S |

8. Limiting values

Table 5. Limiting values  
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol                | Parameter                              | Conditions                                                                                          | Notes | Values     | Unit |
|-----------------------|----------------------------------------|-----------------------------------------------------------------------------------------------------|-------|------------|------|
| T <sub>stg</sub>      | storage temperature                    |                                                                                                     |       | -40 to 125 | °C   |
| T <sub>j,op</sub>     | operating junction temperature         |                                                                                                     |       | -40 to 150 | °C   |
| T <sub>j,max</sub>    | maximum junction temperature           | Intermittent condition with shortened lifetime                                                      |       | -40 to 175 | °C   |
| V <sub>ISOL</sub>     | RMS isolation voltage                  | T <sub>j</sub> = 25 °C; all terminals shorted; f = 50 Hz; t = 1 s                                   |       | 3500       | V    |
| MOSFET                |                                        |                                                                                                     |       |            |      |
| V <sub>DS</sub>       | drain-source voltage                   | T <sub>j</sub> = 25 °C                                                                              |       | 1200       | V    |
| V <sub>GS,max</sub>   | gate-source voltage                    | Absolute maximum values                                                                             |       | -12 to 24  | V    |
| V <sub>GS,op</sub>    | gate-source voltage                    | Recommended operational values                                                                      |       | -4 to 18   | V    |
| P <sub>tot</sub>      | total power dissipation                | T <sub>h</sub> = 25 °C                                                                              |       | 91         | W    |
| I <sub>D</sub>        | drain current                          | V <sub>GS</sub> = 18 V; T <sub>h</sub> = 25 °C                                                      |       | 59         | A    |
|                       |                                        | V <sub>GS</sub> = 18 V; T <sub>h</sub> = 100 °C                                                     |       | 37         | A    |
| I <sub>DM</sub>       | peak drain current                     | pulse width t <sub>p</sub> limited by T <sub>j,max</sub>                                            |       | 118        | A    |
| E <sub>as</sub>       | single pulse drain-to-source avalanche | I <sub>AS</sub> = 30 A; L = 1 mH; V <sub>DD</sub> = 100 V; T <sub>j(init)</sub> = 25 °C; per MOSFET |       | 450        | mJ   |
| Body Diode            |                                        |                                                                                                     |       |            |      |
| I <sub>SD</sub>       | DC body diode forward current          | V <sub>GS</sub> = -4 V; T <sub>h</sub> = 25 °C                                                      |       | 30         | A    |
| I <sub>SD,pulse</sub> | Pulse body diode current               | verified by design, t <sub>p</sub> limited by T <sub>j,max</sub>                                    |       | 118        | A    |

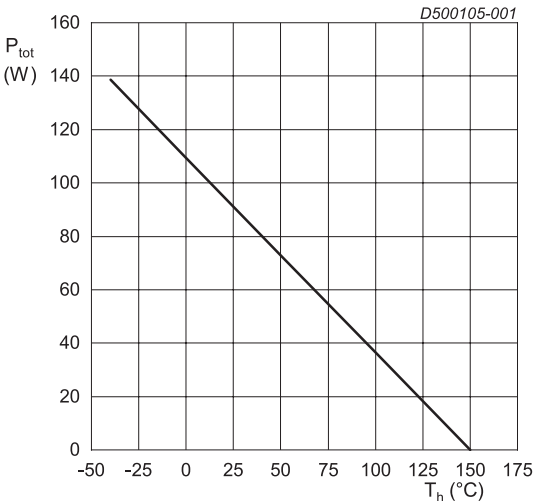


Fig. 1. Power dissipation as a function of heatsink temperature; maximum values

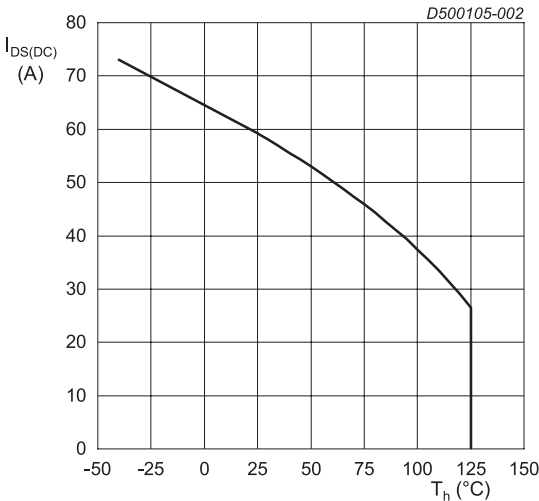


Fig. 2. Continuous Drain Current as a function of heatsink temperature

9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol             | Parameter                                    | Conditions                                                                                                | Notes | Min                     | Typ  | Max | Unit |
|--------------------|----------------------------------------------|-----------------------------------------------------------------------------------------------------------|-------|-------------------------|------|-----|------|
| $R_{th(j-c)}$      | thermal resistance from junction to case     | per MOSFET                                                                                                |       | -                       | 0.59 | -   | K/W  |
| $R_{th(j-h)}$      | thermal resistance from junction to heatsink | per MOSFET, $\lambda_{grease} = 1 \text{ W/(m}\cdot\text{K)}$ , $thick_{grease} = 50 \text{ }\mu\text{m}$ |       | -                       | 1.37 | -   | K/W  |
| Internal Isolation |                                              | basic insulation (class 1, IEC 61140)                                                                     |       | $\text{Al}_2\text{O}_3$ |      |     |      |
| $d_{Creep}$        | Creepage distance                            | terminal to heatsink                                                                                      |       | -                       | 11.5 | -   | mm   |
|                    |                                              | terminal to terminal                                                                                      |       | -                       | 6.3  | -   | mm   |
| $d_{Clear}$        | Clearance                                    | terminal to heatsink                                                                                      |       | -                       | 10   | -   | mm   |
|                    |                                              | terminal to terminal                                                                                      |       | -                       | 5    | -   | mm   |
| CTI                | Comperative tracking index                   |                                                                                                           |       | >200                    |      |     |      |
| F                  | Mounting force per clamp                     |                                                                                                           |       | 20                      | -    | 50  | N    |
| G                  | Approximate Weight                           |                                                                                                           |       | -                       | 20   | -   | g    |

Note: Module is ESD sensitive. Handling precautions are recommended.

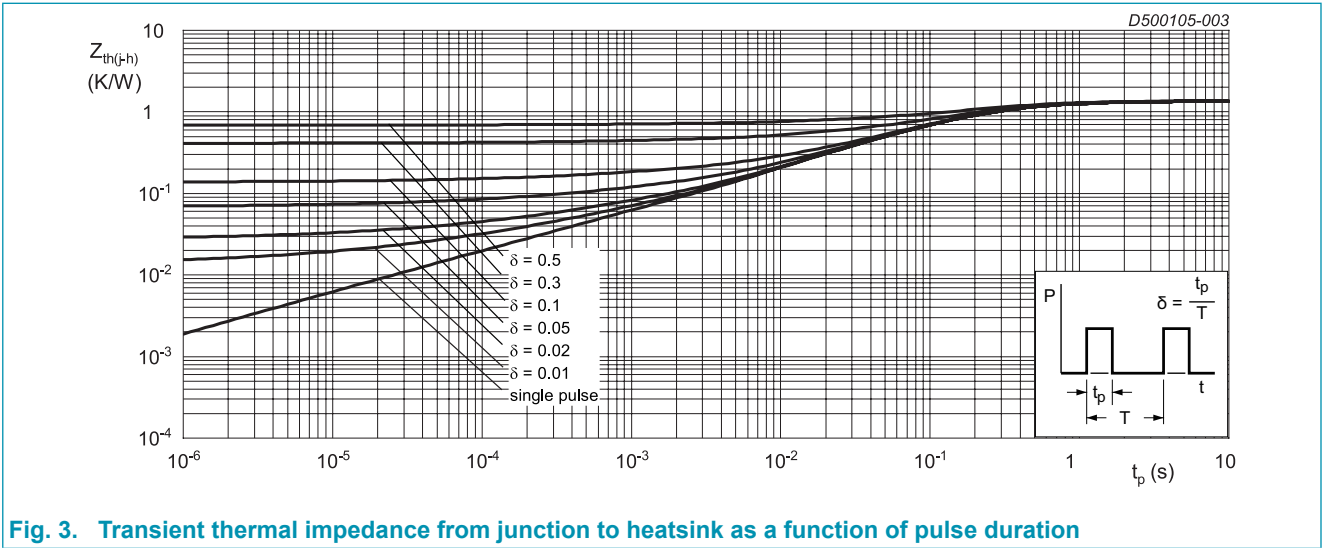


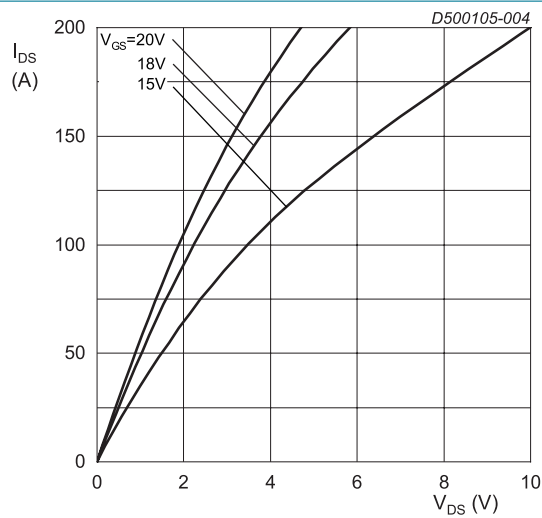
Fig. 3. Transient thermal impedance from junction to heatsink as a function of pulse duration

## 10. Characteristics

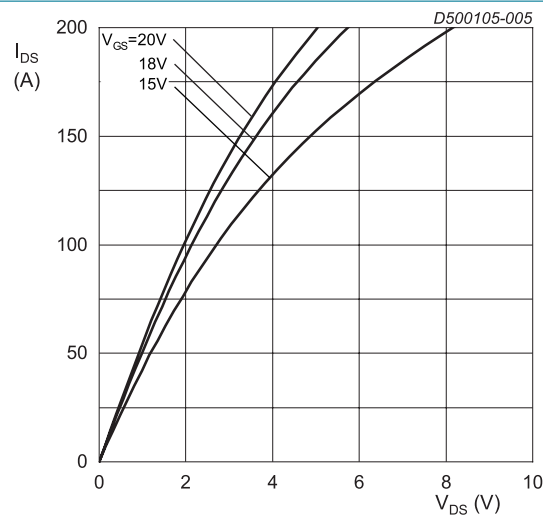
Table 7. Characteristics

| MOSFET                         |                                       |                                                                                                                                   |       |      |      |     |            |
|--------------------------------|---------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------|-------|------|------|-----|------------|
| Symbol                         | Parameter                             | Conditions                                                                                                                        | Notes | Min  | Typ  | Max | Unit       |
| <b>Static characteristics</b>  |                                       |                                                                                                                                   |       |      |      |     |            |
| $V_{(BR)DSS}$                  | drain-source breakdown voltage        | $I_D = 100\ \mu A$ ; $V_{GS} = 0\ V$ ; $T_J = 25\ ^\circ C$                                                                       |       | 1200 | -    | -   | V          |
| $V_{GS(th)}$                   | gate-source threshold voltage         | $I_D = 20\ mA$ ; $V_{DS} = V_{GS}$ ; $T_J = 25\ ^\circ C$                                                                         |       | 1.9  | 2.6  | 3.5 | V          |
|                                |                                       | $I_D = 20\ mA$ ; $V_{DS} = V_{GS}$ ; $T_J = 175\ ^\circ C$                                                                        |       | -    | 1.9  | -   | V          |
| $I_{DSS}$                      | drain leakage current                 | $V_{DS} = 1200\ V$ ; $V_{GS} = 0\ V$ ; $T_J = 25\ ^\circ C$                                                                       |       | -    | 0.2  | 100 | $\mu A$    |
| $I_{GSS}$                      | gate leakage current (absolute value) | $V_{GS} = 24\ V$ ; $V_{DS} = 0\ V$ ; $T_J = 25\ ^\circ C$                                                                         |       | -    | 10   | 100 | nA         |
|                                |                                       | $V_{GS} = -12\ V$ ; $V_{DS} = 0\ V$ ; $T_J = 25\ ^\circ C$                                                                        |       | -    | 10   | 100 | nA         |
| $R_{DS(on)}$                   | drain-source on-state resistance      | $V_{GS} = 15\ V$ ; $I_D = 50\ A$ ; $T_J = 25\ ^\circ C$                                                                           |       | -    | 20   | -   | m $\Omega$ |
|                                |                                       | $V_{GS} = 18\ V$ ; $I_D = 50\ A$ ; $T_J = 25\ ^\circ C$                                                                           |       | -    | 16.3 | 29  | m $\Omega$ |
|                                |                                       | $V_{GS} = 18\ V$ ; $I_D = 50\ A$ ; $T_J = 125\ ^\circ C$                                                                          |       | -    | 24   | -   | m $\Omega$ |
|                                |                                       | $V_{GS} = 18\ V$ ; $I_D = 50\ A$ ; $T_J = 150\ ^\circ C$                                                                          |       | -    | 26   | -   | m $\Omega$ |
|                                |                                       | $V_{GS} = 18\ V$ ; $I_D = 50\ A$ ; $T_J = 175\ ^\circ C$                                                                          |       | -    | 27.3 | -   | m $\Omega$ |
| $R_G$                          | gate resistance                       | $f = 1\ MHz$ ; $T_J = 25\ ^\circ C$ ; per MOSFET                                                                                  |       | -    | 0.6  | -   | $\Omega$   |
| $g_{fs}$                       | transconductance                      | $V_{DS} = 20\ V$ ; $I_D = 50\ A$ ; $T_J = 25\ ^\circ C$                                                                           |       | -    | 32   | -   | S          |
| <b>Dynamic characteristics</b> |                                       |                                                                                                                                   |       |      |      |     |            |
| $Q_{G(tot)}$                   | total gate charge                     | $I_D = 50\ A$ ; $V_{DS} = 800\ V$ ; $V_{GS} = -4\ V/18\ V$ ; $T_J = 25\ ^\circ C$                                                 |       | -    | 215  | -   | nC         |
| $Q_{GS}$                       | gate-source charge                    |                                                                                                                                   |       | -    | 83   | -   | nC         |
| $Q_{GD}$                       | gate-drain charge                     |                                                                                                                                   |       | -    | 32   | -   | nC         |
| $C_{iss}$                      | input capacitance                     | $V_{DS} = 1000\ V$ ; $V_{GS} = 0\ V$ ; $f = 1\ MHz$ ; $T_J = 25\ ^\circ C$                                                        |       | -    | 4701 | -   | pF         |
| $C_{oss}$                      | output capacitance                    |                                                                                                                                   |       | -    | 199  | -   | pF         |
| $C_{rss}$                      | reverse transfer capacitance          |                                                                                                                                   |       | -    | 20   | -   | pF         |
| $E_{oss}$                      | Coss stored energy                    |                                                                                                                                   |       | -    | 100  | -   | $\mu J$    |
| $t_{d(on)}$                    | turn-on delay time                    | $V_{DS} = 800\ V$ ; $V_{GS} = -4\ V/18\ V$ ; $R_{G(ext)} = 5.1\ \Omega$ ; $I_D = 50\ A$ ; $L = 300\ \mu H$ ; $T_J = 25\ ^\circ C$ |       | -    | 23   | -   | ns         |
| $t_r$                          | rise time                             |                                                                                                                                   |       | -    | 16   | -   | ns         |
| $t_{d(off)}$                   | turn-off delay time                   |                                                                                                                                   |       | -    | 64   | -   | ns         |
| $t_f$                          | fall time                             |                                                                                                                                   |       | -    | 19   | -   | ns         |
| $E_{on}$                       | turn-on energy                        |                                                                                                                                   |       | -    | 877  | -   | $\mu J$    |
| $E_{off}$                      | turn-off energy                       |                                                                                                                                   |       | -    | 237  | -   | $\mu J$    |

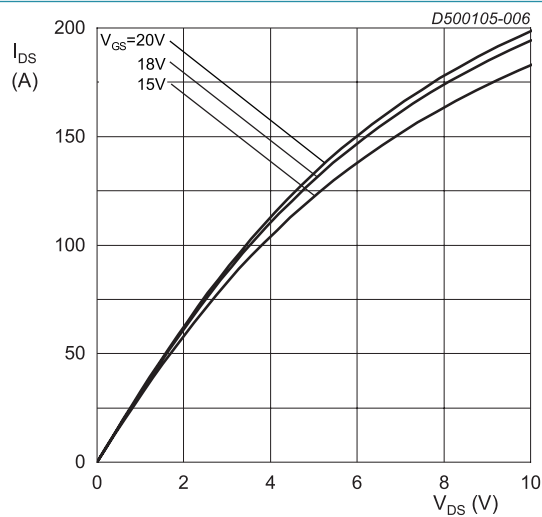
| Body diode              |                               |                                                                                                                                                            |       |        |      |     |      |
|-------------------------|-------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------|-------|--------|------|-----|------|
| Symbol                  | Parameter                     | Conditions                                                                                                                                                 | Notes | Min    | Typ  | Max | Unit |
| Static characteristics  |                               |                                                                                                                                                            |       |        |      |     |      |
| V <sub>SD</sub>         | source-drain voltage          | V <sub>GS</sub> = -4 V; I <sub>SD</sub> = 50 A; T <sub>j</sub> = 25 °C                                                                                     |       | -      | 5.5  | -   | V    |
|                         |                               | V <sub>GS</sub> = -4 V; I <sub>SD</sub> = 50 A; T <sub>j</sub> = 150 °C                                                                                    |       | -      | 5.0  | -   | V    |
| Dynamic characteristics |                               |                                                                                                                                                            |       |        |      |     |      |
| I <sub>rrm</sub>        | reverse recovery current      | I <sub>SD</sub> = 50 A; V <sub>GS</sub> = -4 V/18 V; V <sub>R</sub> = 600 V;<br>di/dt = 2300 A/μs; R <sub>G(ext)</sub> = 5.1 Ω;<br>T <sub>j</sub> = 25 °C  |       | -      | 67   | -   | A    |
| t <sub>rr</sub>         | reverse recovery time         |                                                                                                                                                            |       | -      | 27   | -   | ns   |
| Q <sub>r</sub>          | recovered charge              |                                                                                                                                                            |       | -      | 1072 | -   | nC   |
| E <sub>rec</sub>        | reverse recovery energy       |                                                                                                                                                            |       | -      | 178  | -   | μJ   |
| I <sub>rrm</sub>        | reverse recovery current      | I <sub>SD</sub> = 50 A; V <sub>GS</sub> = -4 V/18 V; V <sub>R</sub> = 600 V;<br>di/dt = 3000 A/μs; R <sub>G(ext)</sub> = 5.1 Ω;<br>T <sub>j</sub> = 150 °C |       | -      | 74   | -   | A    |
| t <sub>rr</sub>         | reverse recovery time         |                                                                                                                                                            |       | -      | 29   | -   | ns   |
| Q <sub>r</sub>          | recovered charge              |                                                                                                                                                            |       | -      | 1368 | -   | nC   |
| E <sub>rec</sub>        | reverse recovery energy       |                                                                                                                                                            |       | -      | 207  | -   | μJ   |
| NTC thermistor          |                               |                                                                                                                                                            |       |        |      |     |      |
| Symbol                  | Parameter                     | Conditions                                                                                                                                                 | Notes | Min    | Typ  | Max | Unit |
| R <sub>25</sub>         | Rated resistance              | T <sub>NTC</sub> = 25 °C                                                                                                                                   |       | -      | 5000 | -   | Ω    |
| R <sub>100</sub>        |                               | T <sub>NTC</sub> = 100 °C                                                                                                                                  |       | 465±5% |      |     | Ω    |
| B <sub>25/50</sub>      | B-value                       | R <sub>2</sub> = R <sub>25</sub> exp[B <sub>25/50</sub> (1/T <sub>2</sub> - 1/(298.15K))]                                                                  |       | 3380   |      |     | K    |
|                         | Maximum operating temperature |                                                                                                                                                            |       | -      | 200  | -   | °C   |
|                         | Dissipation costant           |                                                                                                                                                            |       | -      | 2    | -   | mW/K |
|                         | Thermal time constant         |                                                                                                                                                            |       | -      | ≤10  | -   | s    |



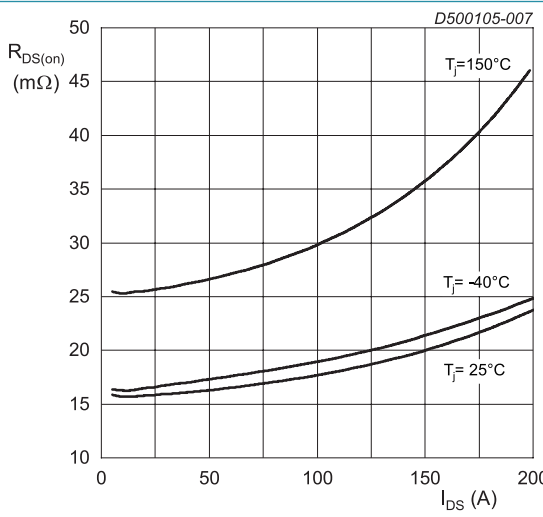
**Fig. 4.** Output characteristics; drain current as a function of drain-source voltage; typical values



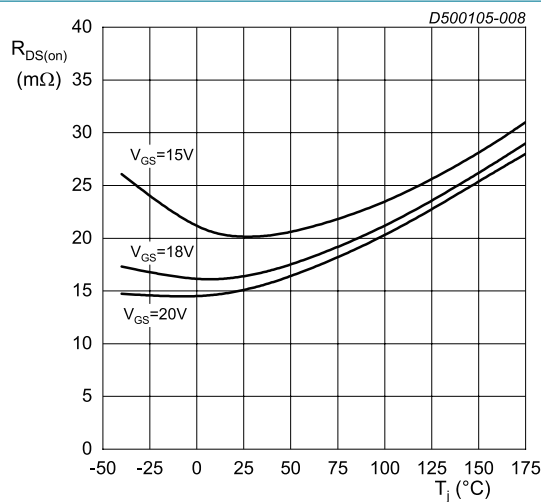
**Fig. 5.** Output characteristics; drain current as a function of drain-source voltage; typical values



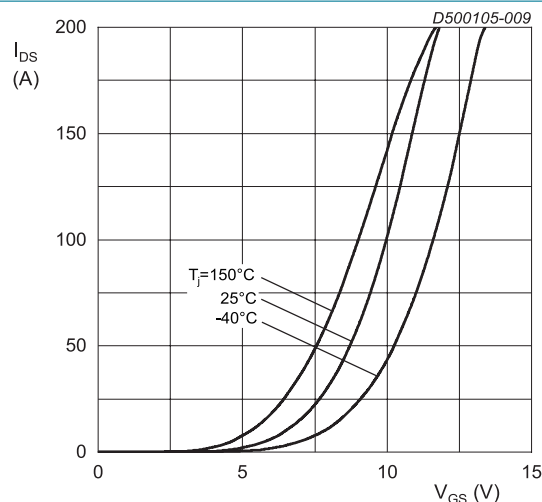
**Fig. 6.** Output characteristics; drain current as a function of drain-source voltage; typical values



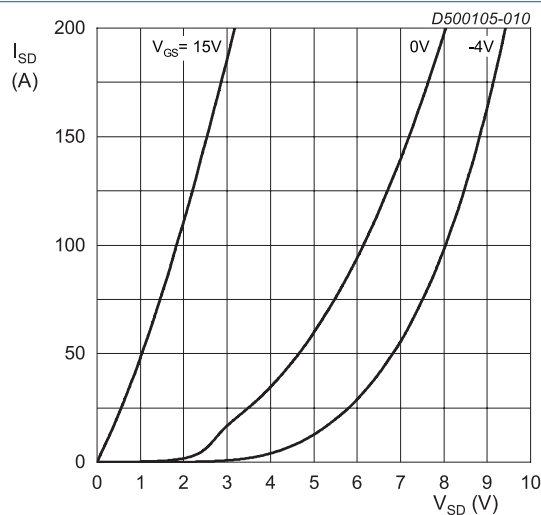
**Fig. 7.** Drain-source on-state resistance as a function of drain current; typical values



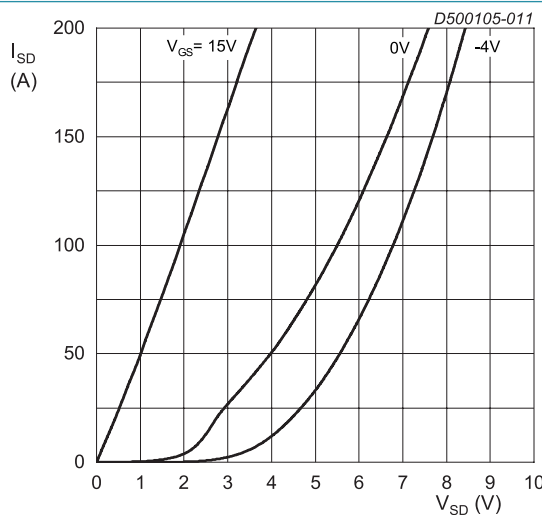
$I_{DS} = 50\text{ A}; t_p < 200\text{ }\mu\text{s}$   
**Fig. 8. Drain-source on-state resistance as a function of junction temperature**



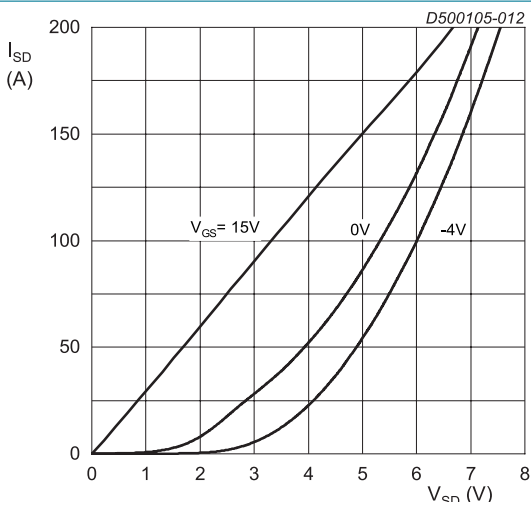
$V_{DS} = 20\text{ V}; t_p < 200\text{ }\mu\text{s}$   
**Fig. 9. Transfer characteristics; drain current as a function of gate-source voltage; typical values**



$T_j = -40\text{ }^\circ\text{C}; t_p < 200\text{ }\mu\text{s}$   
**Fig. 10. Body diode forward characteristics; typical values**

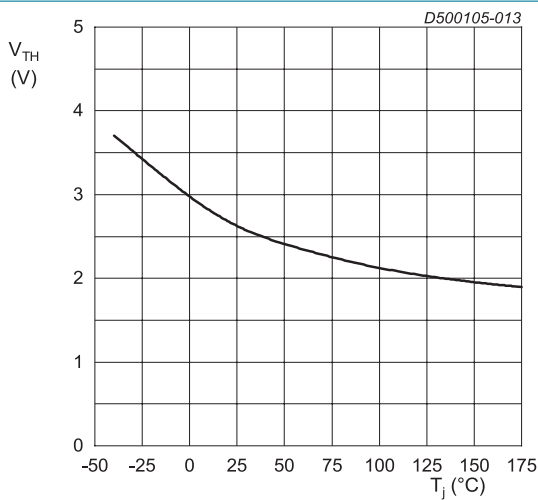


$T_j = 25\text{ }^\circ\text{C}; t_p < 200\text{ }\mu\text{s}$   
**Fig. 11. Body diode forward characteristics; typical values**



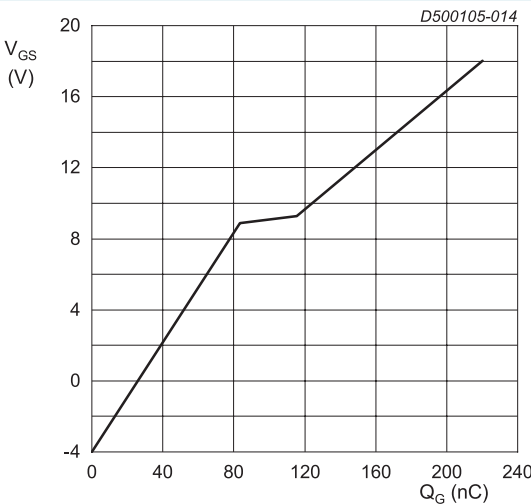
$T_j = 150\text{ }^{\circ}\text{C}$ ;  $t_p < 200\text{ }\mu\text{s}$

Fig. 12. Body diode forward characteristics; typical values



$V_{DS} = V_{GS}$ ;  $I_{DS} = 20\text{ mA}$

Fig. 13. Threshold voltage as a function of junction temperature



$I_{DS} = 50\text{ A}$ ;  $I_{GS} = 0.1\text{ mA}$ ;  $V_{DS} = 800\text{ V}$ ;  $T_j = 25\text{ }^{\circ}\text{C}$

Fig. 14. Gate-source voltage as a function of gate charge; typical values

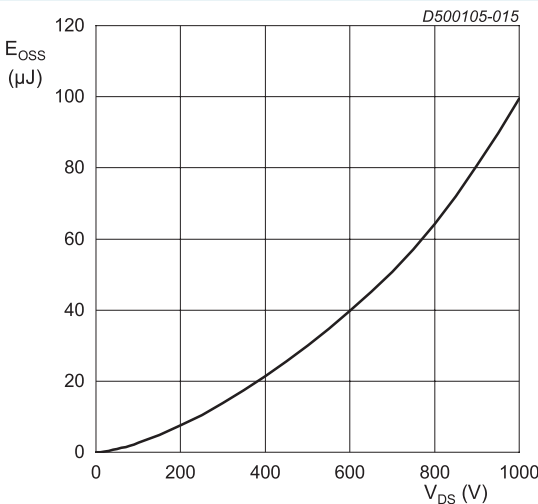
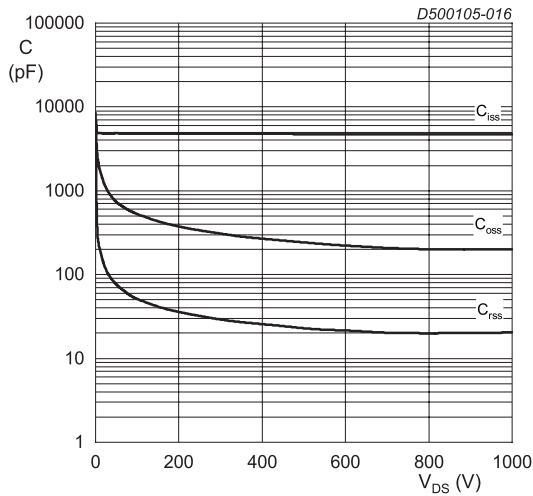
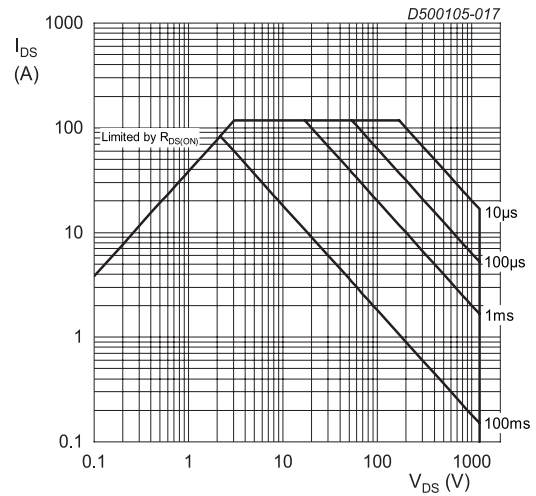


Fig. 15. Output capacitor stored energy as a function of drain-source voltage



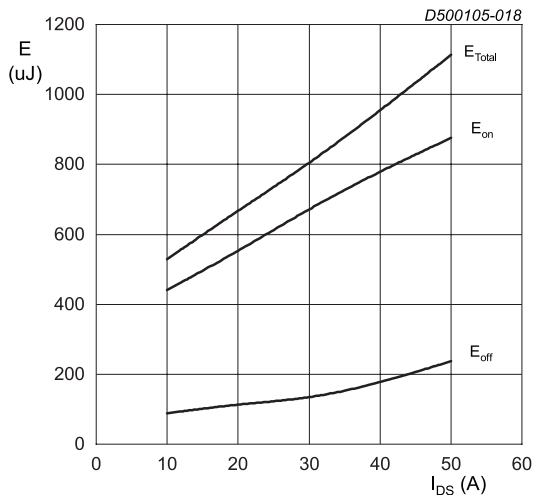
$V_{DS} = 0 - 1000 \text{ V}$   
 $T_j = 25^\circ\text{C}$ ;  $V_{AC} = 25 \text{ mV}$ ;  $f = 1 \text{ MHz}$

**Fig. 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values**



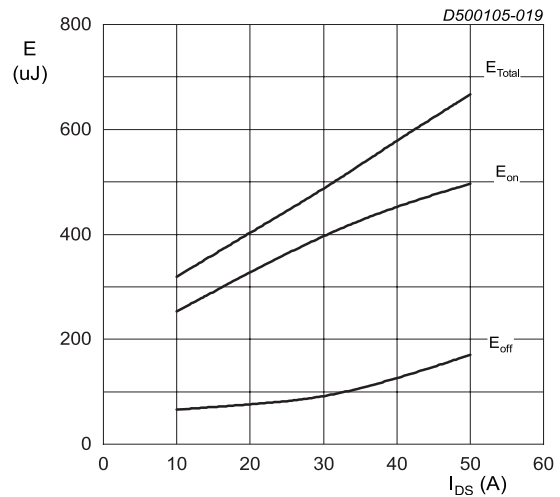
$T_j = 25^\circ\text{C}$ ;  $D = 0$   
 Parameter:  $t_p$

**Fig. 17. Forward bias safe operating area**



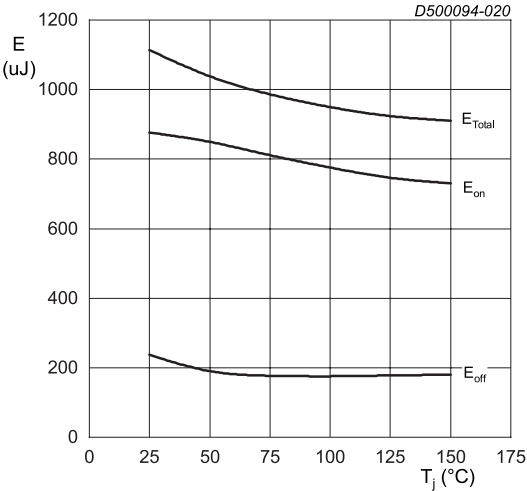
$T_j = 25^\circ\text{C}$ ;  $V_{DD} = 800 \text{ V}$ ;  $R_{G(off)} = 5.1 \Omega$ ;  $R_{G(on)} = 5.1 \Omega$ ;  
 $V_{GS} = -4 \text{ V/18 V}$ ;  $L = 300 \mu\text{H}$

**Fig. 18. Clamped Inductive Switching Energy as a function of drain current**



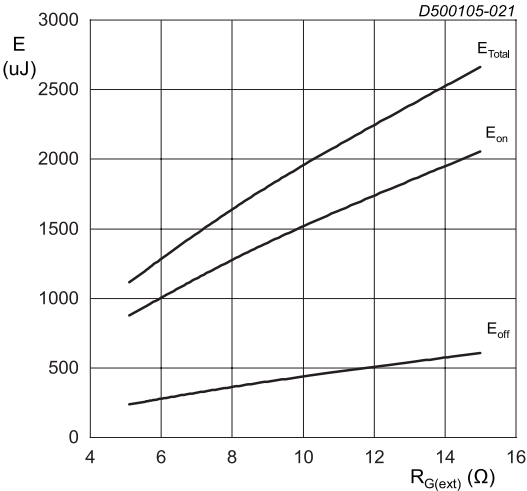
$T_j = 25^\circ\text{C}$ ;  $V_{DD} = 600 \text{ V}$ ;  $R_{G(off)} = 5.1 \Omega$ ;  $R_{G(on)} = 5.1 \Omega$ ;  
 $V_{GS} = -4 \text{ V/18 V}$ ;  $L = 300 \mu\text{H}$

**Fig. 19. Clamped Inductive Switching Energy as a function of drain current**



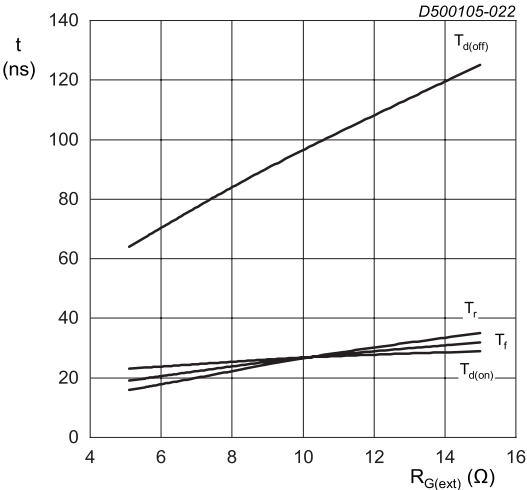
I<sub>DS</sub> = 50 A; V<sub>DD</sub> = 800 V; R<sub>G(off)</sub> = 5.1 Ω; R<sub>G(on)</sub> = 5.1 Ω;  
V<sub>GS</sub> = -4 V/18 V; L = 300 μH

Fig. 20. Clamped Inductive Switching Energy as a function of junction temperature



T<sub>j</sub> = 25 °C; V<sub>DD</sub> = 800 V; I<sub>DS</sub> = 50 A; V<sub>GS</sub> = -4 V/18 V;  
L = 300 μH

Fig. 21. Clamped Inductive Switching Energy as a function of external gate resistance



T<sub>j</sub> = 25 °C; V<sub>DD</sub> = 800 V; I<sub>DS</sub> = 50 A; V<sub>GS</sub> = -4 V/18 V;  
L = 300 μH

Fig. 22. Switching time as a function of external gate resistance

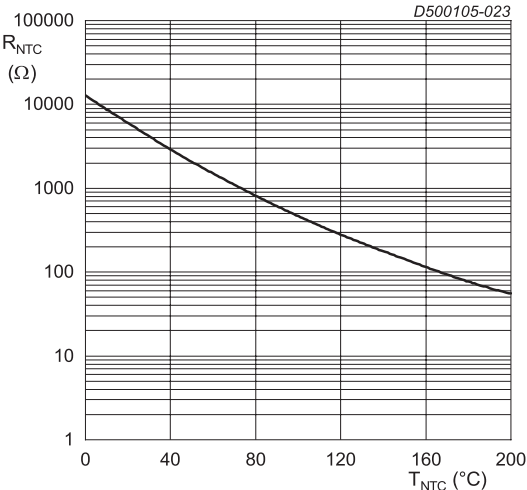
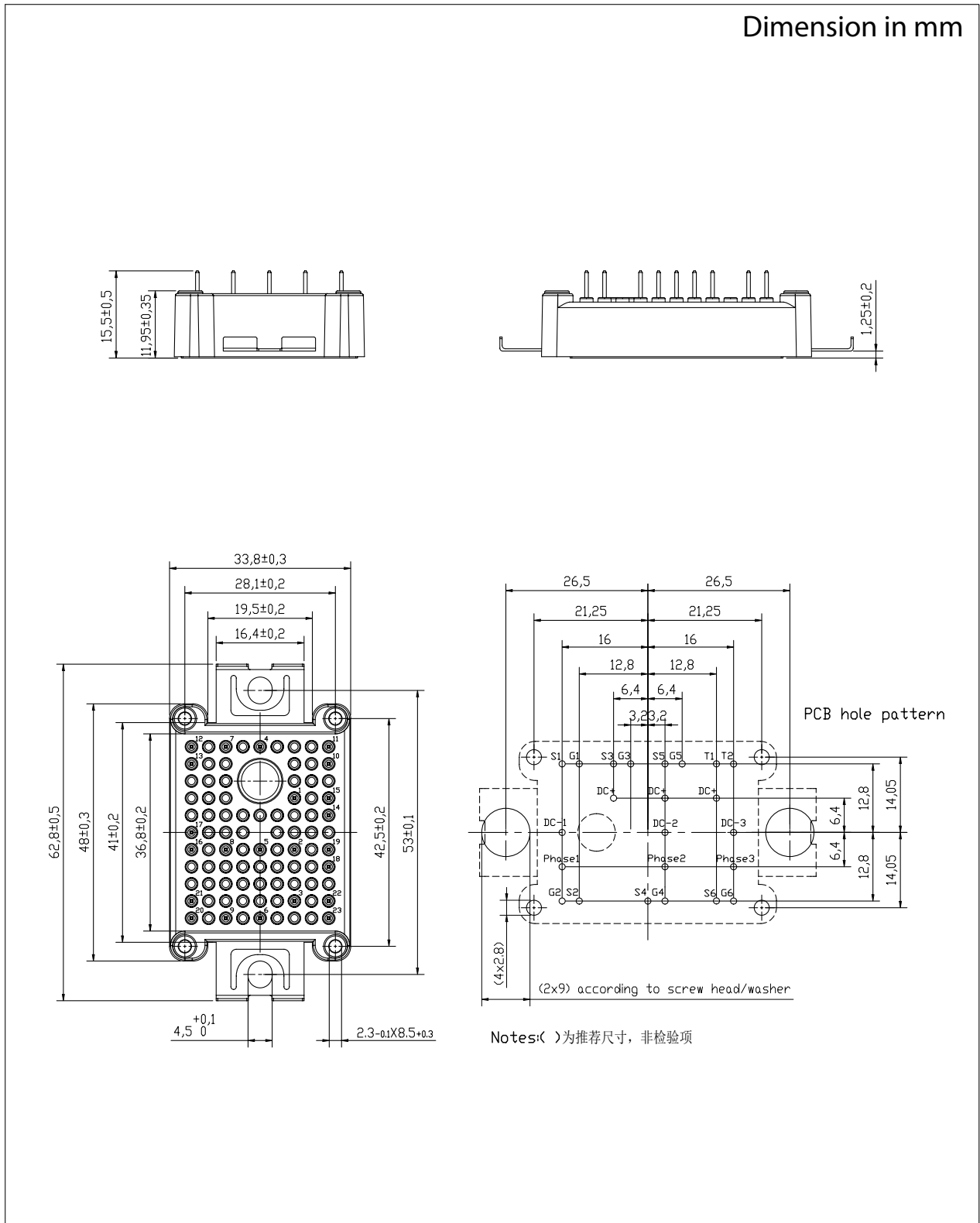


Fig. 23. NTC thermistor resistance as a function of NTC temperature

## 11. Package outline



## 12. Legal information

### Data sheet status

| Document status [1][2]         | Product status [3] | Definition                                                                            |
|--------------------------------|--------------------|---------------------------------------------------------------------------------------|
| Objective [short] data sheet   | Development        | This document contains data from the objective specification for product development. |
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